

**Search Notes**

Application/Control No.

10/611,334

Examiner

Hsien-ming Lee

Applicant(s)/Patent under  
Reexamination

HECK ET AL.

Art Unit

2823

**SEARCHED**

Class	Subclass	Date	Examiner
438	25,51	3/2/2007	LEE
438	106-108	3/2/2007	LEE
438	113	3/2/2007	LEE
257	414,678	3/2/2007	LEE
257	684,704	3/2/2007	LEE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST attached (USPAT, USPG, USOCR, EPO, JPO, IBM, Derwent)	2/27/2007	LEE
EAST attached (USPAT, USPG)	3/2/2007	LEE